Propagation of Shear-Horizontal Acoustic Waves in a Quartz Plate with a Fluid Layer for Liquid Sensor Application

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Abstract

We study the propagation of shear-horizontal (SH) waves in a quartz plate in contact with a viscous fluid layer of a finite thickness as an acoustic wave sensor for measuring fluid viscosity or density. Mindlin's first-order plate theory and the theory of Newtonian fluids are used. An equation for determining the dispersion relations of the SH waves is obtained. Approximate dispersion relations for long waves are given analytically. Numerical results showing the effects of the fluid on SH wave characteristics are presented.

1. Introduction

Resonant frequencies (or waves speed when a propagating wave is considered in a waveguide) of an elastic body can be affected by many effects like a temperature change or initial stresses, etc. Therefore, frequency shifts in a vibrating elastic body (resonator) can be used to make various so-called acoustic wave sensors. Sometimes piezoelectric crystals are used so that the operating mode or wave can be directly excited and detected electrically. Otherwise transducers are needed for the excitation and detection of acoustic waves.

Specifically, a resonator when in contact with a viscous fluid changes its resonance frequencies due to the inertia and viscosity of the fluid. This effect has been used to make fluid sensors for measuring fluid viscosity or density [1-3]. More references can be found in relevant review articles [4,5]. For fluid sensor applications, vibration modes of an elastic body without a normal displacement at its surface are ideal. In these modes, no pressure waves are generated in the fluid. The fluid produces a drag only on the body surface due to the fluid viscosity and the tangential motion of the surface, thereby lowering the resonance frequencies of the body.

Certain shear modes in plates called thickness-shear (TSh) are widely used for fluid sensor applications [1-3]. Theoretically, these modes can only exist in unbounded plates without edge effects. In these modes, motions of material particles are parallel to the surfaces of the plates, and particle velocities only vary along the plate thickness direction, without in-plane variations. From the viewpoint of wave propagation, TSh modes in a plate are waves propagating along the thickness direction of the plate and are bounced back and forth between the surfaces of the plate. The wave vector is parallel to the plate thickness direction, and the in-plane wave numbers are zero or the in-plane wave lengths are infinite. These TSh waves or modes are the idealized operating modes of many acoustic wave devices.

In reality, however, due to the finite size of devices, pure TSh modes cannot exist because of edge effects. Therefore, in real devices, usually the operating modes are in fact related to waves whose wave vectors have a small in-plane component. These waves have been referred to as essentially TSh waves, or transversely varying TSh waves. In the case when the transverse variation is in a direction perpendicular to the TSh particle velocity, the corresponding waves are called thickness-twist (TT) waves. These transversely varying waves are long waves in plates whose in-plane wave lengths are much larger than the plate thickness. Both stationary waves in resonators and propagating waves in waveguides have been used for resonators and sensors. Understanding the behavior of long waves in plates is fundamentally important to plate acoustic wave devices.

The propagation of waves in crystal plates, elastic or piezoelectric, has been an active research subject for a long time [6-11]. In particular, waves in plates in contact with a fluid have been studied for fluid sensor applications, e.g., [12,13]. Due to material anisotropy, modeling of crystal devices using the three-dimensional (3D) theory of elasticity or piezoelectricity usually involves considerable mathematical difficulties. In fluid sensor applications, this is further complicated by the fluid-structure interaction. Although long equations for determining the wave dispersion relations can often be formulated, they are typically involved with transcendental equations with multi-valued solutions and complex roots. Therefore, numerical search for the roots of the frequency equation is usually needed which presents various challenges.

For the analysis of plate acoustic wave devices, in a series of papers [14-17], Mindlin and his coworkers developed and refined two-dimensional (2D) equations for motions of crystal plates. The 2D plate equations make theoretical and numerical analysis possible in many practically useful cases [18-23]. The 2D equations effectively reduce the dimension of the problem by one, which is a significant simplification. In addition, the plate equations usually are only involved with the particular operating mode of a device plus a few other modes that are coupled to the mode of interest. Therefore, mode identification when using 2D equations is much simpler than when using 3D equations.

In this paper, we use Mindlin's first-order plate equations to study SH waves in a quartz crystal plate in contact with a viscous fluid layer. In addition to pure TSh modes [24,25], we are mainly interested in the propagation of long waves and how they are affected by the presence of the fluid [26]. The fluid in [26] occupies a semi-infinite space. In this paper, we study the effect of a fluid layer with a finite thickness. The use of 2D plate equations simplifies the problem and allows us to obtain some simple, fundamental and analytical results useful to the understanding and design of plate wave fluid sensors.

2. Two-Dimensional Plate Equations

The equations for crystal plates vary considerably according to the symmetry of the crystals. Quartz is a crystal widely used for acoustic wave devices. Therefore we focus on quartz in the following. Quartz has very weak piezoelectric coupling. For frequency analysis, the small piezoelectric coupling may be neglected and an elastic analysis is usually sufficient. This is common practice in the frequency analysis of resonant quartz devices. A particular cut of a quartz plate refers to the orientation of the plate when it is taken out of an anisotropic bulk quartz crystal. As a consequence, quartz plates of different cuts exhibit different anisotropies in coordinates normal and parallel to the plate surfaces. Rotated Y-cut quartz plates are effectively monoclinic. They include the most frequently used AT-cut quartz plates as a special case. In this section, we summarize the 2D plate equations for rotated Y-cut quartz [14,16]. Consider such a plate as shown in Fig. 1. It is in contact with a Newtonian fluid layer of thickness *H*. For rotated Y-cut quartz plates, SH (or antiplane) motions with only one displacement component are allowed by the linear theory of anisotropic elasticity. These motions are particularly useful in device applications. They are described by

$$u_1 = u_1(x_2, x_3, t), \quad u_2 = u_3 = 0,$$
 (1)

where **u** is the displacement vector. u_1 is governed by [27]

$$c_{66}u_{1,22} + c_{55}u_{1,33} + 2c_{56}u_{1,23} = \rho \ddot{u}_1.$$
⁽²⁾

Exact solutions to (2) may be attempted for relatively simple problems. Due to c_{56} , solving (2) is not straightforward and the results are usually complicated. (2) includes all SH modes. Since an acoustic wave device usually operates with a particular mode, it is simpler to use 2D plate equations which describe the modes of interest only. The ideal operating mode is TSh which does not have x_1 and x_3 dependence. The variation of these modes along x_1 has been reasonably well understood. Therefore this paper is concerned with the x_3 dependence only without the x_1 dependence, i.e., the so-called straight-crested waves or modes. For straight-crested SH motions, the displacement field of the first-order plate theory is approximated by [14,16]

$$u_1(x_2, x_3, t) = u_1^{(0)}(x_3, t) + x_2 u_1^{(1)}(x_3, t),$$
(3)

where $u_1^{(0)}(x_3,t)$ is the face-shear (FS) displacement, and $u_1^{(1)}(x_3,t)$ is the fundamental TT displacement. When $u_1^{(1)}(x_3,t)$ is independent of x_3 , it reduces to the fundamental TSh displacement which is the ideal mode of an infinite plate. Both $u_1^{(0)}$ and $u_1^{(1)}$ have tangential surface displacements only and are very useful for fluid sensor application. They are governed by the following plate equations of motion [14,16]:

$$T_{31,3}^{(0)} + 2bT_1^{(0)} = 2b\rho\ddot{u}_1^{(0)}, \qquad (4a)$$

$$T_{31,3}^{(1)} - T_{21}^{(0)} + \frac{2b^3}{3}T_1^{(1)} = \frac{2b^3}{3}\rho\ddot{u}_1^{(1)}.$$
(4b)

The plate resultants $T_{31}^{(0)}$, $T_{21}^{(0)}$ and $T_{31}^{(1)}$ over a cross section of the plate represent plate internal forces and moments. They are related to the plate displacements $u_1^{(0)}$ and $u_1^{(1)}$ by the following constitutive relations [14,16]:

$$T_{31}^{(0)} = 2b(c_{55}u_{1,3}^{(0)} + \kappa_1 c_{56}u_1^{(1)}),$$
(5a)

$$T_{12}^{(0)} = 2b(\kappa_1 c_{56} u_{1,3}^{(0)} + \kappa_1^2 c_{66} u_1^{(1)}),$$
(5b)

$$T_{31}^{(1)} = \frac{2b^3}{3} \left(\gamma_{55} u_{1,3}^{(1)} + \psi_{35} \phi_{,3}^{(1)} \right), \tag{5c}$$

where c_{pq} is the usual elastic stiffness, $\gamma_{55} = 1/s_{55}$, and s_{pq} is the elastic compliance. κ_1 in the above equations is a shear correction factor [14,16] which will be determined later. The mechanical surface loads in (4) are defined by

$$T_{1}^{(0)} = \frac{1}{2b} \Big[T_{21} (b^{-}) - T_{21} (-b^{-}) \Big],$$

$$T_{1}^{(1)} = \frac{3}{2b^{3}} \Big[b T_{21} (b^{-}) + b T_{21} (-b^{-}) \Big],$$
(6)

where b^- is the lower limit of *b*. The substitution of (5) into (4) gives two equations for $u_1^{(0)}$ and $u_1^{(1)}$:

$$c_{55}u_{1,33}^{(0)} + \kappa_1 c_{56}u_{1,3}^{(1)} + T_1^{(0)} = \rho \ddot{u}_1^{(0)} , \qquad (7a)$$

$$\gamma_{55}u_{1,33}^{(1)} - 3b^{-2}(\kappa_1c_{56}u_{1,3}^{(0)} + \kappa_1^2c_{66}u_1^{(1)}) + T_1^{(1)} = \rho\ddot{u}_1^{(1)}.$$
(7b)

Clearly, c_{56} causes the coupling between $u_1^{(0)}$ and $u_1^{(1)}$. Therefore, a coupled analysis is necessary. (7) has spatial derivatives with respective to x_3 only but not x_2 due to the plate approximation, and therefore is much simpler than (2).

	$\mathbf{\uparrow} x_2$
Free space	
Fluid	$\bigwedge H$
Quartz	$b x_3$
	↓ b

Free space

Fig. 1. A crystal plate with a fluid layer

3. Thickness-shear Vibration

The shear correction factor κ_1 in the plate equations in the previous section is determined by requiring the resonance frequency of the fundamental TSh mode calculated from the 3D exact equations and the 2D plate equations to be the same [14,16]. The relevant 3D solution was given in [24]. In this section we calculate the 2D solution and determine κ_1 . Consider an unbounded plate. Whether the fluid is compressible or not does not matter because the motion to be considered is a pure shear without volume change. For time-harmonic motions, we use the usual complex notation. All fields have the same $\exp(i\omega t)$ factor which will be dropped below for simplicity.

3.1 Fluid

The equation of motion for the fluid is [28]

$$T_{21,2} = \rho_L \dot{v}_1, \tag{8}$$

where the shear stress is given by

$$T_{21} = \mu \frac{\partial v_1}{\partial x_2} \ . \tag{9}$$

 μ and ρ_L are the viscosity and mass density of the fluid. v_1 and T_{21} are the relevant velocity and shear stress components. The velocity field can be determined as

$$v_1 = \{C_1 \sinh[(1+i)\eta(x_2 - b)] + C_2 \cosh[(1+i)\eta(x_2 - b)]\},$$
(10)

where C_1 and C_2 are undetermined constants, and

$$\eta = \sqrt{\frac{\rho_L \omega}{2\mu}} \,. \tag{11}$$

The shear stress needed for boundary and continuity conditions is

$$T_{21} = (1+i)\mu\eta \{C_1 \cosh[(1+i)\eta(x_2-b)] + C_2 \sinh[(1+i)\eta(x_2-b)]\}.$$
 (12)

3.2 Crystal Plate

For thickness vibrations independent of x_3 , with the use of (6), (7) reduces to

$$\frac{1}{2b} \left[T_{21} \left(b^{-} \right) - T_{21} \left(-b^{-} \right) \right] = \rho \ddot{u}_{1}^{(0)},$$

$$- 3b^{-2} \kappa_{1}^{2} c_{66} u_{1}^{(1)} + \frac{3}{2b^{3}} \left[b T_{21} \left(b^{-} \right) + b T_{21} \left(-b^{-} \right) \right] = \rho \ddot{u}_{1}^{(1)}.$$
(13)

The bottom of the plate surface is traction free, with $T_{21}(-b^-) = 0$. At the top of the plate the shear stress is continuous, i.e., $T_{21}(b^-) = T_{21}(b^+)$ where b^+ is the upper limit of *b*. With these, (13) becomes

$$\frac{1}{2b}T_{21}(b^{+}) = \rho \ddot{u}_{1}^{(0)},$$

$$-3b^{-2}\kappa_{1}^{2}c_{66}u_{1}^{(1)} + \frac{3}{2b^{2}}T_{21}(b^{+}) = \rho \ddot{u}_{1}^{(1)}.$$
(14)

We let

$$u_1^{(0)} = C_3 \exp(i\omega t), \quad u_1^{(1)} = C_4 \exp(i\omega t)$$
 (15)

where C_3 and C_4 are undetermined constants.

3.3 Boundary and Continuity Conditions

At the top of the fluid layer, we have the following traction-free condition:

$$T_{21}(b+H) = 0.$$
 (16)

At the interface between the crystal plate and the fluid, we have the continuity of particle velocity:

$$\dot{u}_1^{(0)} + b\dot{u}_1^{(1)} = v_1(b^+) \quad . \tag{17}$$

The substitution of the relevant fields in (10), (12), and (15) into (14), (16) and (17) results in four linear and homogeneous equations for C_1 through C_4 :

$$\cosh[(1+i)\eta H]C_{1} + \sinh[(1+i)\eta H]C_{2} = 0,
C_{2} - i\omega C_{3} - i\omega bC_{4} = 0,
(1+i)\mu\eta C_{1} + 2\rho b\omega^{2}C_{3} = 0,
3(1+i)\mu\eta C_{1} + (2\rho b^{2}\omega^{2} - 6\kappa_{1}^{2}c_{66})C_{4} = 0.$$
(18)

For nontrivial solutions the determinant of the coefficient matrix of (18) has to vanish, which gives the following frequency equation:

$$\omega^{2} - \frac{3\kappa_{1}^{2}c_{66}}{\rho b^{2}} = \frac{(1-i)\mu\eta}{2\rho b\omega} \left(\frac{3\kappa_{1}^{2}c_{66}}{\rho b^{2}} - 4\omega^{2}\right) \tanh\left[(1+i)\eta H\right].$$
(19)

3.4 Correction Factor

The exact fundamental TSh frequency from the 3D equations when the fluid is not present is given by [29]

$$\omega_0 = \frac{\pi}{2b} \sqrt{\frac{c_{66}}{\rho}} \,. \tag{20}$$

When the plate is in contact with a low viscosity fluid layer, the fundamental TSh frequency is approximately given by [24]

$$\omega = \omega_0 (1 + \Delta \Omega) , \qquad (21)$$

where [24]

$$\Delta\Omega = -\frac{1-i}{\pi} \sqrt{\frac{\rho_L \mu \omega_0}{2\rho c_{66}}} \tanh[(1+i)\eta_0 H], \qquad (22)$$

$$\eta_0 = \sqrt{\rho_L \omega_0 / (2\mu)} \,. \tag{23}$$

Substitution of (21) into (19) determines

$$\kappa_1^2 = \frac{\pi^2}{12} \left(1 - \Delta \Omega \right). \tag{24}$$

We note that (24) is complex. Its real part is a frequency shift. Its imaginary part describes damped modes due to viscosity.

4. Propagation of Face-shear and Thickness-twist Waves

With κ_1 determined, the plate equations are ready to be used to study propagating waves in the plate which is the main purpose of this paper. We begin with coupled FS and TT waves and then examine uncoupled long FS and long TT waves separately.

4.1 Coupled Waves

For propagating waves with both x_2 and x_3 dependence, the equations for the fluid are

$$T_{21,2} + T_{31,3} = \rho_L \dot{v}_1,$$

$$T_{21} = \mu \frac{\partial v_1}{\partial x_2}, \quad T_{31} = \mu \frac{\partial v_1}{\partial x_2}.$$
(25)

Substituting the stresses in (25) into the equation of motion in (25) gives

$$\mu(v_{1,22} + v_{1,33}) = \rho_L \dot{v}_1 . \tag{26}$$

We consider the following propagating waves:

$$v_{1} = \left\{ C_{1} \sinh\left[\sqrt{\zeta^{2} - 2i\eta^{2}}(x_{2} - b)\right] + C_{2} \cosh\left[\sqrt{\zeta^{2} - 2i\eta^{2}}(x_{2} - b)\right] \right\} \exp[i(\zeta x_{3} - \omega t)], \quad (27)$$

where C_1 and C_2 are undetermined constants, and (11) is still valid. For propagating waves in the crystal plate, we have

$$c_{55}u_{1,33}^{(0)} + \kappa_{1}c_{56}u_{1,3}^{(1)} + \frac{1}{2b}T_{21}(b^{+}) = \rho\ddot{u}_{1}^{(0)},$$

$$\gamma_{55}u_{1,33}^{(1)} - 3b^{-2}(\kappa_{1}c_{56}u_{1,3}^{(0)} + \kappa_{1}^{2}c_{66}u_{1}^{(1)}) + \frac{3}{2b^{3}}T_{21}(b^{+}) = \rho\ddot{u}_{1}^{(1)}.$$
(28)

At the top of the fluid layer the traction-free boundary condition in (16) still holds. The continuity of velocity at the top of the plate surface given by (17) is still valid too. Let

$$u_1^{(0)} = C_3 \exp[i(\zeta x_3 - \omega t)], \quad u_1^{(1)} = C_4 \exp[i(\zeta x_3 - \omega t)], \quad (29)$$

where C_3 and C_4 are undetermined constants. The substitution of (27) and (29) into (16), (17) and (28) yields the following four linear and homogeneous equations for C_1 through C_4 :

$$C_{1} + C_{2} \tanh\left(\sqrt{\zeta^{2} - 2i\eta^{2}}H\right) = 0,$$

$$C_{2} + i\omega C_{3} + ib\omega C_{4} = 0,$$

$$\frac{\mu\sqrt{\zeta^{2} - 2i\eta^{2}}}{2b}C_{1} + (\rho\omega^{2} - c_{55}\zeta^{2})C_{3} + i\kappa_{1}c_{56}\zeta C_{4} = 0,$$

$$\frac{3}{2}\mu\sqrt{\zeta^{2} - 2i\eta^{2}}C_{1} - 3i\kappa_{1}c_{56}\zeta C_{3} + (\rho b^{2}\omega^{2} - \gamma_{55}b^{2}\zeta^{2} - 3\kappa_{1}^{2}c_{66})C_{4} = 0.$$
(30)

For nontrivial solutions, the determinant of the coefficient matrix has to vanish, which, together with (11), gives the flowing frequency equation that determines the dispersion relation of ω versus ζ :

$$(iAB\omega + \rho\omega^{2} - c_{55}\zeta^{2})(3iABb^{2}\omega + \rho b^{2}\omega^{2} - \gamma_{55}b^{2}\zeta^{2} - 3\kappa_{1}^{2}c_{66}) - (iABb\omega + i\kappa_{1}c_{56}\zeta)(3iABb\omega - 3i\kappa_{1}c_{56}\zeta) = 0,$$
(31)

where

$$A = \frac{\mu\sqrt{\zeta^2 - 2i\eta^2}}{2b}, \quad B = \tanh\left(\sqrt{\zeta^2 - 2i\eta^2}H\right). \tag{32}$$

In device applications usually long waves with a small or infinitesimal ζ are used. Therefore, we expand the relevant terms in (31) into power series of ζ and neglect powers higher than two. Then (31) may be written as

$$F(\omega)\zeta^2 + G(\omega) = 0, \qquad (33)$$

where

$$F(\omega) = 4A_{1}B_{2}i\rho b^{2}\omega^{3} + 4A_{2}B_{1}i\rho b^{2}\omega^{5/2} - A_{1}B_{1}i\gamma_{55}b^{2}\omega^{3/2} -3A_{1}B_{2}i\kappa_{1}^{2}c_{66}\omega - 3A_{2}B_{1}i\kappa_{1}^{2}c_{66}\omega^{1/2} - 3A_{1}B_{1}ic_{55}b^{2}\omega^{3/2} -\gamma_{55}\rho b^{2}\omega^{2} - c_{55}\rho b^{2}\omega^{2} + 3\kappa_{1}^{2}c_{66}c_{55} - 3\kappa_{1}^{2}c_{56}^{2},$$

$$G(\omega) = 4A_{1}B_{1}i\rho b^{2}\omega^{7/2} - 3A_{1}B_{1}i\kappa_{1}^{2}c_{66}\omega^{3/2} + \rho^{2}b^{2}\omega^{4} - 3\kappa_{1}^{2}c_{66}\rho\omega^{2},$$
(34)

and

$$A_{1} = \frac{1}{2b}\sqrt{-i\mu\rho_{L}}, \quad A_{2} = \frac{1}{4b}\sqrt{\frac{i\mu^{3}}{\rho_{L}}},$$

$$B_{1}(\omega) = \tanh\left(\sqrt{-2i\eta^{2}}H\right), \quad B_{2}(\omega) = \frac{H\left[1-\tanh^{2}\left(\sqrt{-2i\eta^{2}}H\right)\right]}{2}\sqrt{\frac{i\mu}{\rho_{L}}}.$$
(35)

In the special case when the fluid is not present, for thickness modes with $\zeta=0$, (33) determines two frequencies of 0 and ω_0 . For small but nonzero values of ζ , (33) determines two dispersion relations for FS and TT waves. The FS branch goes through the origin $(\omega, \zeta) = (0,0)$. The TT branch has a finite intercept at $(\omega, \zeta) = (\omega_0, 0)$ and ω_0 is called the cutoff frequency below which the TT wave becomes a exponential function of x_3 and cannot propagate. When the fluid is present, for low-viscosity fluids, we expect the two branches are modified slightly and discuss them separately below.

4.2 Long FS Waves

For the FS branch, when ζ is small, ω is also small and is of the same order (see [30] for the case when the fluid is not present). In this case, neglecting higher powers of ω , (33) may be approximated by

$$(3\kappa_1^2 c_{66} c_{55} - 3\kappa_1^2 c_{56}^2)\zeta^2 = 3\kappa_1^2 c_{66}\rho\omega^2 + 3A_1 B_1 i\kappa_1^2 c_{66}\omega^{3/2},$$
(36)

where the effect of the fluid is represented by the second term on the right-hand side. When the fluid is not present and the crystal plate is alone, denoting the wave frequency by ω_{Plate} , (36) reduces to the following known dispersion relation for long FS waves [30]:

$$\omega_{\text{Plate}} = \sqrt{\frac{c_{66}c_{55} - c_{56}^2}{\rho c_{66}}} \zeta = \sqrt{\frac{\gamma_{55}}{\rho}} \zeta , \qquad (37)$$

which is nondispersive. An immediate observation is that the second term on the right-hand side of (36) makes the waves dispersive. For numerical results, an AT-cut quartz plate with b=1mm is used, which is a typical thickness for quartz devices. For the fluid, we choose as an example chloroform with $\rho_L = 1.483 \times 10^3 \text{ kg/m}^3$ and a relatively low viscosity of $\mu = 0.542$ mPa·s (smaller than the viscosity of water). We consider real frequencies and solve (36) for complex wave numbers. For figure plotting we introduce the following dimensionless frequencies and wave number:

$$\Omega = \frac{\omega}{\omega_0}, \quad \Omega_{\text{Plate}} = \frac{\omega_{\text{Plate}}}{\omega_0}, \quad Z = \frac{\zeta}{\pi/(2b)} = X + iY.$$
(38)

Long waves are described by small values of the real part of Z.

Figure 2 shows the effect of viscosity on the dispersion relation of long FS waves. The viscosity of chloroform is artificially varied while other parameters are fixed. Figure 2 (a) shows a fundamental and qualitative effect of the fluid viscosity which changes the dispersion curve from real to complex indicating attenuation due to fluid viscosity, and from a straight line to a curve showing dispersion. Figure 2 (b) shows the real part of the dispersion relation which is essentially linear and hence the fluid induced dispersion is small. Figure 2 (c) shows the difference between the real parts of (36) and (37), in which the fluid induced dispersion becomes visible. It can be seen from Fig. 2 (c) that, although long waves are usually used in real devices, the frequency shift is larger when the wave number X is larger or the wave is shorter. This is because shorter waves have lager velocity gradients in the x_3 direction and hence a larger viscous stress T_{31} . Figure 2 (c) also shows that the fluid lowers the frequency, and higher viscosity causes more frequency shift. The relative frequency shift is of the order of 10⁻⁵ which is considered a significant frequency change because the thermal noise in crystal resonators is typically of the order of 10^{-6} . Therefore a 10^{-5} frequency shift is a clear and measurable signal. Figure 2 (d) shows the imaginary part of the complex wave number. It is positive, representing attenuation for the right-traveling waves given in (29). For a fixed frequency, higher viscosity causes larger attenuation.



Figure 3 shows the effect of the fluid density. The behaviors in Fig. 3 are similar to those in Fig. 2. This is as expected because, as shown in (22), the fluid viscosity and density appear together in a product in the first-order approximation of the frequency shift. In a typical application, one

needs to know either the fluid density or viscosity and then uses an acoustic wave fluid sensor to measure the other. How to separate the density from viscosity is a challenging problem in acoustic wave fluid sensors.



Figure 4 shows the effect of the fluid layer thickness *H*. The cases of H=0.5b and H=1b are indistinguishable in the figure. In this case, effectively, the fluid layer can be treated as a semi-infinite half space [26]. The frequency shift is an increasing function of *H* for small H only [24]. When *H* reaches a certain value, there exists a maximum frequency shift after which the frequency shift decreases with *H* [24]. What is shown in Fig. 4 (c) is the case when a large *H* has a small frequency shift.



4.3 Long TT Waves

For the TT branch of the dispersion relations, when ζ is small, ω is finite. In this case, we denote

$$\omega = \omega_0 (1 + \Delta \Omega), \tag{39}$$

where $\Delta\Omega$ is small. Substituting (39) into (31), for small $\Delta\Omega$, we obtain

$$\frac{\omega - \omega_0}{\omega_0} = \Delta \Omega = -\frac{D_3}{D_4} - \frac{D_1 D_4 - D_2 D_3}{D_4^2} \zeta^2, \tag{40}$$

where

$$\begin{split} D_{1} &= 4A_{1}B_{2}^{0}i\rho b^{2}\omega_{0}^{3} + 4A_{2}B_{1}^{0}i\rho b^{2}\omega_{0}^{5/2} - A_{1}B_{1}^{0}i\gamma_{55}b^{2}\omega_{0}^{3/2} \\ &- 3A_{1}B_{2}^{0}i\kappa_{1}^{2}c_{66}\omega_{0} - 3A_{2}B_{1}^{0}i\kappa_{1}^{2}c_{66}\omega_{0}^{1/2} - \gamma_{55}\rho b^{2}\omega_{0}^{2} - 3A_{1}B_{1}^{0}ic_{55}b^{2}\omega_{0}^{3/2} \\ &- c_{55}\rho b^{2}\omega_{0}^{2} + 3\kappa_{1}^{2}c_{66}c_{55} - 3\kappa_{1}^{2}c_{56}^{2}, \\ D_{2} &= 12A_{1}B_{2}^{0}i\rho b^{2}\omega_{0}^{3} + 10A_{2}B_{1}^{0}i\rho b^{2}\omega_{0}^{5/2} - \frac{3}{2}A_{1}B_{1}^{0}i\gamma_{55}b^{2}\omega_{0}^{3/2} - 3A_{1}B_{2}^{0}i\kappa_{1}^{2}c_{66}\omega_{0} \qquad (41) \\ &- \frac{3}{2}A_{2}B_{1}^{0}i\kappa_{1}^{2}c_{66}\omega_{0}^{1/2} - 2\gamma_{55}\rho b^{2}\omega_{0}^{2} - \frac{9}{2}A_{1}B_{1}^{0}ic_{55}b^{2}\omega_{0}^{3/2} - 2c_{55}\rho b^{2}\omega_{0}^{2}, \\ D_{3} &= 4A_{1}B_{1}^{0}i\rho b^{2}\omega_{0}^{7/2} - 3A_{1}B_{1}^{0}i\kappa_{1}^{2}c_{66}\omega_{0}^{3/2} + \rho^{2}b^{2}\omega_{0}^{4} - 3\kappa_{1}^{2}c_{66}\rho\omega_{0}^{2}, \\ D_{4} &= 14A_{1}B_{1}^{0}i\rho b^{2}\omega_{0}^{7/2} - \frac{9}{2}A_{1}B_{1}^{0}i\kappa_{1}^{2}c_{66}\omega_{0}^{3/2} + 4\rho^{2}b^{2}\omega_{0}^{4} - 6\kappa_{1}^{2}c_{66}\rho\omega_{0}^{2}. \end{split}$$

In (41), for low-viscosity fluids, since B_1 and B_2 are always multiplied with A_1 or A_2 which depend on μ , B_1 and B_2 have been approximated by

$$B_1^0(\omega) \cong B_1(\omega_0), \quad B_2^0(\omega) \cong B_2(\omega_0). \tag{42}$$

(40) shows that locally, near cutoff, the dispersion curve may be approximated by a parabola and therefore long TT waves are dispersive. When $\zeta = 0$, (40) reduces to

$$\omega = \omega_0 \left(1 - \frac{D_3}{D_4} \right), \tag{43}$$

which is complex. Numerical results for the effects of fluid viscosity, density, and layer thickness on long TT waves are shown in Figs. 5, 6, and 7, respectively. When there is no fluid, part of the dispersion curve of TT waves is real and the rest is purely imaginary. The dispersion curve does not go through the origin. It has a finite intercept with the Ω axis which is the cutoff frequency. The basic effects of the fluid on long TT waves are similar to the case of FS waves. The dispersion curve becomes complex. TT waves are with higher frequencies than FS waves and therefore decay faster in the fluid.



(a)



(b) Fig. 5. Effects of fluid viscosity on TT waves, H=2b



(a)



(b) Fig. 6. Effects of fluid density on TT waves, H=2b



(a)



Fig. 7. Effects of fluid layer thickness on TT waves (*H*=0.005*b* and *H*=0.02*b* overlap)

5. Conclusions

Analytical solutions are obtained for TSh modes and FS as well as TT waves in a crystal plate carrying a viscous fluid layer with a finite thickness. Approximate expressions for frequency shifts and dispersion relations are presented. The frequencies and dispersion relations become complex due to the fluid, indicating damped modes and waves with attenuation. The fluid viscosity and density lower the frequencies together in a combined manner, causing (additional) dispersion. Shorter waves have larger frequency shifts. Long FS waves become dispersive due to the fluid. Typical relative frequency shifts are of the order of 10⁻⁵ which are detectable by crystal resonators and waveguides. The results obtained are fundamental and useful for the understanding and design of quartz crystal fluid sensors.

References

- [1] K. K. Kanazawa, J. G. Gordon II, The oscillation frequency of a quartz resonator in contact with a liquid, Analytica Chimica Acta, 175, 99-105, 1985.
- [2] F. Josse, Z. A. Shana, D. E. Radtke, D. T. Haworth, Analysis of piezoelectric bulk-acousticwave resonators as detectors in viscous conductive liquids, IEEE Trans. Ultrason., Ferroelec., Freq. Contr., 37, 359-368, 1990.
- [3] C. E. Reed, K. K. Kanazawa, J. H. Haufman, Physical description of a viscoelastically loaded AT-cut quartz resonator, J. Apl. Phys., 68, 1993-2001, 1990.
- [4] E. Benes, Improved quartz crystal microbalance technique, J. Appl. Phys., 56, 608-626, 1984.
- [5] E. Benes, M. Gröschl, W. Burger, M. Schmid, Sensors based on piezoelectric resonators, Sensors and Actuators, A48, 1-21, 1995.
- [6] J. L. Bleustein, Some simple modes of wave propagation in an infinite piezoelectric plate, Journal of Acoustical Society of Amermican, 45, 614-620, 1969.
- [7] G. H. Schmidt, On anti-symmetric waves in an unbounded piezoelectric plate with axisymmetric electrodes, International Journal of Solids and Structures, 13, 179-195, 1977.

- [8] G. H. Schmidt, Resonances of an unbounded piezoelectric plate with circular electrodes, International Journal of Engineering Science, 15, 495-510, 1977.
- [9] H. S. Paul, D. P. Raju and T. R. Balakrishnan, Free vibrations of a piezoelectric layer of hexagonal (6mm) class, International Journal of Engineering Science, 21, 691-704, 1983.
- [10] S. Syngellakis and P. C. Y. Lee, Piezoelectric wave dispersion curves for infinite anisotropic plates, J. Appl. Phys., 73, 7152-7161, 1993.
- [11] J. T. Stewart and Y. K. Yong, Exact analysis of the propagation of acoustic waves in multilayered anisotropic piezoelectric plates, IEEE Transactions on Ultrasonics, Ferroelectrics, and Frequency Control, 40, 375-390, 1994.
- [12] F. Peng, H. Liu and S. Y. Hu, Love wave propagation in a layered piezoelectric structure immersed in a fluid, Key Engineering Materials, 306-308, 1211-1216, 2006.
- [13] F. L. Guo and R. Sun, Propagation of Bleustein-Gulyaev wave in 6mm piezoelectric materials loaded with viscous fluid, International Journal of Solids and Structures, 45, 3699-3710, 2008.
- [14] R. D. Mindlin, High frequency vibrations of crystal plates, Quart. Appl. Math., 19, 51-61, 1961.
- [15] H. F. Tiersten and R. D. Mindlin, Forced vibrations of piezoelectric crystal plates, Quart. Appl. Math., 20, 107-119, 1962.
- [16] R. D. Mindlin, High frequency vibrations of piezoelectric crystal plates, Int. J. Solids Structures, 8, 895-906, 1972.
- [17] P. C. Y. Lee, S. Syngellakis and J. P. Hou, A two-dimensional theory for high-frequency vibrations of piezoelectric crystal plates with or without electrodes, J. Appl. Phys, 61, 1249-1262, 1987.
- [18] R. D. Mindlin and P. C. Y. Lee, Thickness-shear and flexural vibrations of partially plated, crystal plates, Int. J. Solids Structures, 2, 125-139, 1966.
- [19] J. Wang, P. C. Y. Lee and D. H. Bailey, Thickness-shear and flexural vibrations of linearly contoured crystal strips with multiprecision computation, Computers & Structures 70, 437-445, 1999.
- [20] J. Wang and W. H. Zhao, The determination of the optimal length of crystal blanks in quartz crystal resonators, IEEE Trans. Ultrason., Ferroelec., Freq. Contr., 52, 2023-2030, 2005.
- [21] P. C. Y. Lee and M. S. H. Tang, Initial stress field and resonance frequencies of incremental vibrations in crystal resonators by finite element method, in: Proc. of the 40th Annual Freq Contr Symp, 1986, pp. 152-160.
- [22] Y.-K. Yong and J. T. Stewart, Mass-frequency influence surface, mode shapes, and frequency spectrum of a rectangular AT-cut quartz plate, IEEE Trans. Ultrason., Ferroelec., Freq. Contr., 38, 67-73, 1991.
- [23] J. Wang and J. S. Yang, Higher-order theories of piezoelectric plates and applications, Appl. Mech. Rev. 53, 87-99, 2000.
- [24] B. Liu, Q. Jiang and J. S. Yang, Fluid-induced frequency shift in a piezoelectric plate driven by lateral electric fields, International Journal of Applied Electromagnetics and Mechanics, 34, 171-180, 2010.
- [25] B. Liu, Q. Jiang and J. S. Yang, Frequency shifts in a quartz plate piezoelectric resonator in contact with a viscous fluid under a separated electrode, Int. J. of Applied Electromagnetics and Mechanics, 35, 177-187, 2011.
- [26] B. Liu, J. S. Yang and Q. Jiang, Analysis of shear-horizontal waves propagating in a piezoelectric plate in contact with a semi-infinite fluid for fluid sensor application, World Journal of Engineering, 9, 529-540, 2012.
- [27] J. S. Yang, An Introduction to the Theory of Piezoelectricity, Springer, 2005, p. 57.
- [28] R. L. Panton, Incompressible Flow, John Wiley and Sons, New York, 1984.

- [29] H. F. Tiersten, A corrected modal representation of thickness vibrations in quartz plates and its influence on the transversely varying case, IEEE Trans. Ultrason., Ferroelect., Freq. Contr., 50, 1436-1443, 2003.
- [30] R. D. Mindlin, Face-shear waves in rotated Y-cut quartz plates, Mechanics of the Solid State, F. P. J. Rimrott and J. Schwaighofer (eds.), University of Toronto Press, 1968, pp. 143-145.